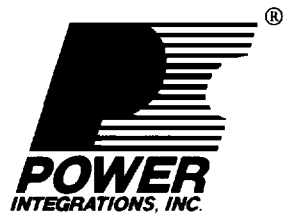


INT200

Low-side Driver IC

Low-side Drive and High-side Control with Simultaneous Conduction Lockout



Product Highlights

- 5 V CMOS Compatible Control Inputs**
 - Combines logic inputs for low and high-side drives
 - Schmidt-triggered inputs for noise immunity
- Built-in High-voltage Level Shifters**
 - Integrated level shifters simplify high-side interface
 - Can withstand up to 800 V for direct interface to the INT201 high-side driver
 - Pulsed high-voltage level shifters reduce power consumption
- Gate Drive Output for an External MOSFET**
 - Provides 300 mA sink/150 mA source current
 - Can drive MOSFET gate at up to 15 V
 - External MOSFET allows flexibility in design for various motor sizes
- Built-in Protection Features**
 - Simultaneous conduction lockout protection
 - UV lockout

Description

The INT200 Low-side driver IC provides gate drive for an external low-side MOSFET switch and high-side level shifting. When used in conjunction with the INT201 high-side driver, the INT200 provides a simple, cost-effective interface between low-voltage control logic and high-voltage loads. The INT200 is designed to be used with rectified 110 V or 220 V supplies. Both high-side and low-side switches can be controlled independently from ground-referenced 5 V logic inputs on the low side driver.

Built-in protection logic prevents both switches from turning on at the same time and shorting the high voltage supply. Pulsed level shifting saves power and provides enhanced noise immunity. The circuit is powered from a nominal 15 V supply to provide adequate gate drive for external N-channel MOSFETs.

Applications include motor drives, electronic ballasts, and uninterruptible power supplies. The INT200 can also be used to implement full- bridge and multi-phase configurations.

The INT200 is available in 8-pin plastic DIP and SOIC packages.

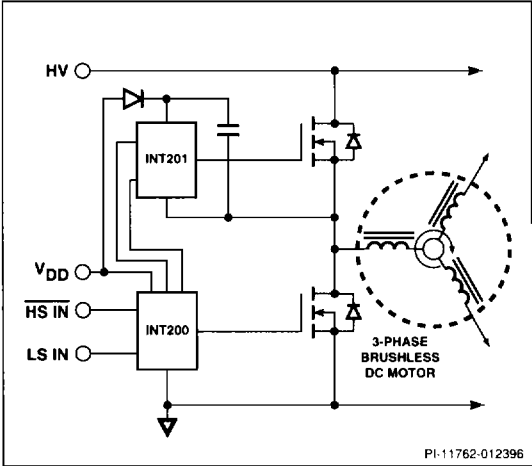


Figure 1. Typical Application

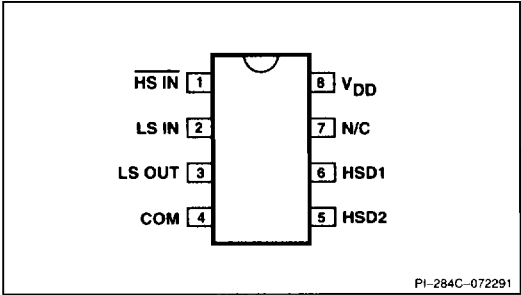


Figure 2. Pin Configuration.

PART NUMBER	PACKAGE OUTLINE	ISOLATION VOLTAGE
INT200PFI1	P08A	600 V
INT200TFI1	T08A	600 V
INT200PFI2	P08A	800 V
INT200TFI2	T08A	800 V



Pin Functional Description

Pin 1:

Active-low logic-level input **HS IN** controls the pulse circuit which signals the INT201 high-side driver.

Pin 2:

Active-high logic level input **LS IN** controls the low side driver output.

Pin 3:

LS OUT is the driver output which controls the low-side MOSFET.

Pin 4:

COM connection; analog reference point for the circuit.

Pin 5:

Level shift output **HSD 2** signals the high-side driver to turn off. One short, precise pulse is sent on each positive transition of HS IN.

Pin 6:

Level shift output **HSD 1** signals the high-side driver to turn on. Two short, precise pulses are sent on each negative transition of HS IN.

Pin 7:

N/C for creepage distance.

Pin 8:

V_{DD} supplies power to the logic, high-side interface, and low-side driver.

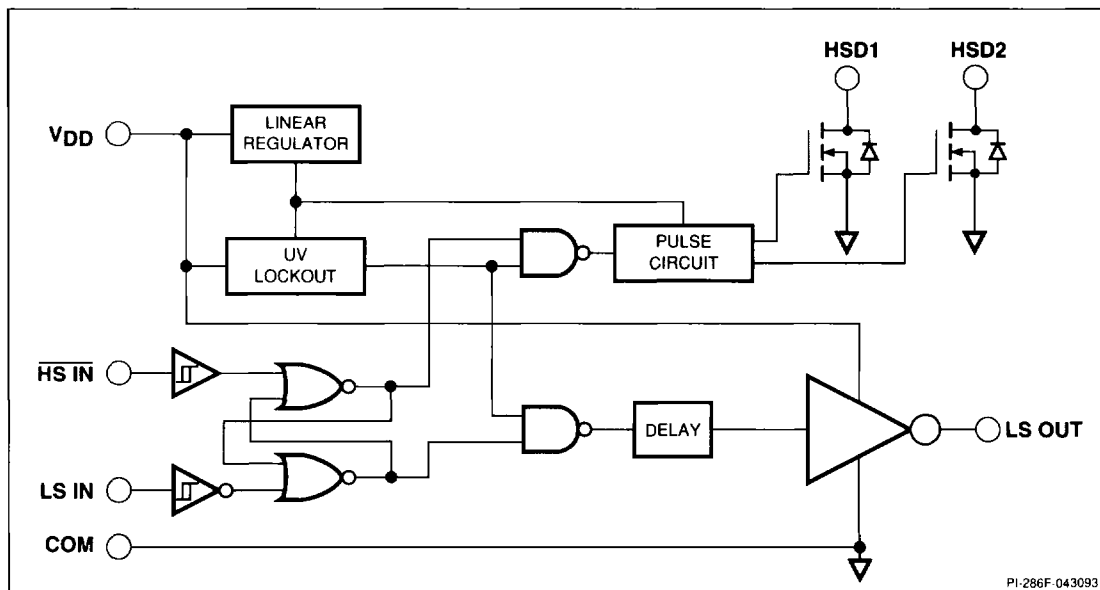


Figure 3. Functional Block Diagram of the INT200

INT200 Functional Description

5 V Regulator

The 5 V linear regulator circuit provides the supply voltage for the control logic and high-voltage level shift circuit. This allows the logic section to be directly compatible with 5 V CMOS logic without the need of an external 5 V supply.

Undervoltage Lockout

The undervoltage lockout circuit disables the LS OUT pin and both HSD pins whenever the V_{DD} power supply falls below typically 9.0 V, and maintains this condition until the V_{DD} power supply rises above typically 9.35 V. This guarantees that both MOSFETs will remain off during power-up or fault conditions.

HSD1/HSD2

The HSD1 and HSD2 outputs are connected to integrated high-voltage N-channel MOSFET transistors which perform the level-shifting function for communication to the high-side driver. Controlled current capability allows the drain voltage to float with the high-side driver. Two individual channels produce a true differential communication channel for accurately controlling the high-side driver in the presence of fast moving high-voltage waveforms.

Pulse Circuit

The pulse circuit provides the two high-voltage level shifters with precise timing signals. Two pulses are sent over HSD1 to signal the high-side driver to turn on. One pulse is sent over HSD2 to signal the high-side driver to turn off. The combination of differential communication with the precise timing provides maximum immunity to noise.

Conduction Latch

An RS latch prevents the low-side driver and high-side driver from being on at the same time, regardless of the input signals.

Delay Circuit

The delay circuit matches the low-side propagation delay with the combination of the pulse circuit, high voltage level shift, and high-side driver propagation delays. This ensures that the low-side driver and high-side driver will never be on at the same time during switching transitions in either direction.

Driver

The CMOS drive circuit provides drive power to the gate of the MOSFET used on the low side of the half bridge circuit. The driver consists of a CMOS buffer capable of driving an external transistor gate at up to 15 V.

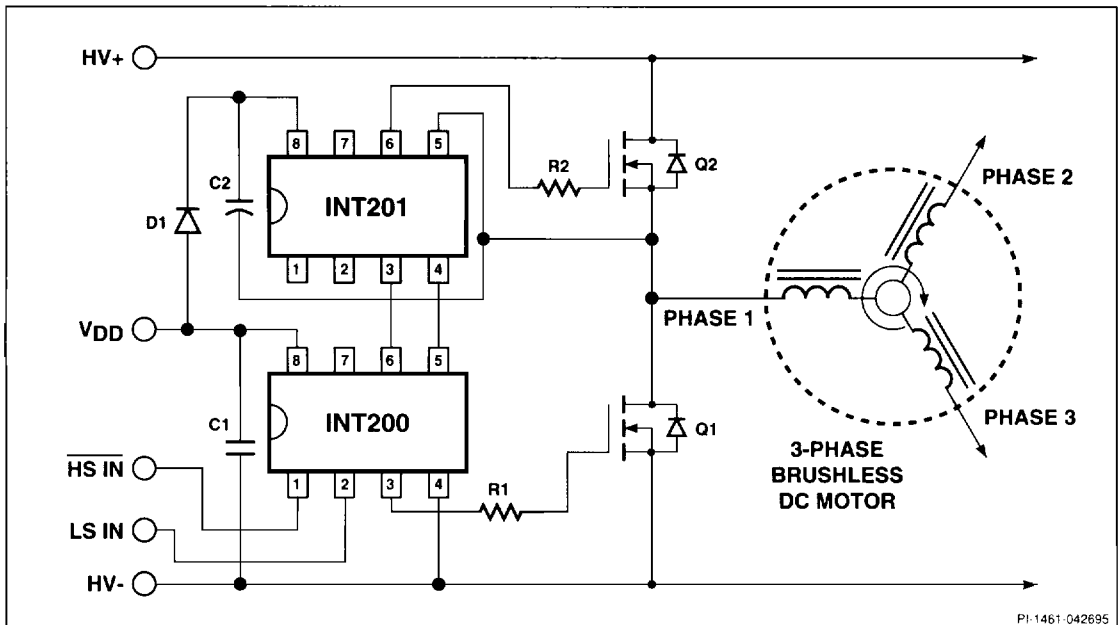


Figure 4. Using the INT200 and INT201 in a 3-phase Configuration.



General Circuit Operation

One phase of a three-phase brushless DC motor drive circuit is shown in Figure 4 to illustrate an application of the INT200/201. The LS IN signal directly controls MOSFET Q1. The HS IN signal causes the INT200 to command the INT201 to turn MOSFET Q2 on or off as required. The INT200 will ignore input signals that would command both Q1 and Q2 to conduct simultaneously, protecting against shorting the HV+ bus to HV-.

Local bypassing for the low-side driver is provided by C1. Bootstrap bias for the high-side driver is provided by D1 and C2. Slew rate and effects of parasitic oscillations in the load waveforms are controlled by resistors R1 and R2.

The inputs are designed to be compatible with 5 V CMOS logic levels and should not be connected to V_{DD} . Normal CMOS power supply sequencing should be observed. The order of signal application

should be V_{DD} , logic signals, and then HV+. V_{DD} should be supplied from a low impedance voltage source.

The length of time that the high-side can remain on is limited by the size of the bootstrap capacitor. Applications with extremely long high-side on times require special techniques discussed in AN-10.

Maximum frequency of operation is limited by power dissipation due to high-voltage switching, gate charge, and bias power. Figure 5 indicates the maximum switching frequency as a function of input voltage and gate charge. For higher ambient temperatures, the switching frequency should be derated linearly.

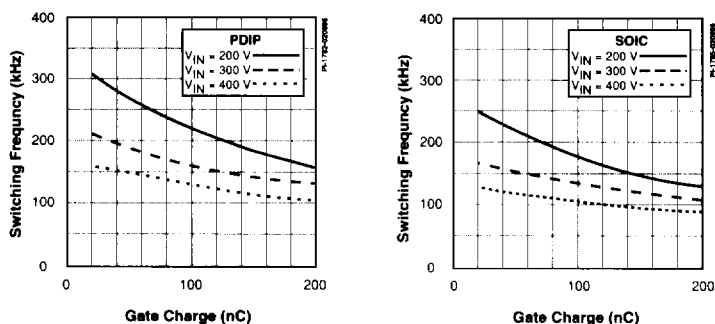


Figure 5. Switching Frequency versus Gate Charge for a) PDIP and b) SOIC.

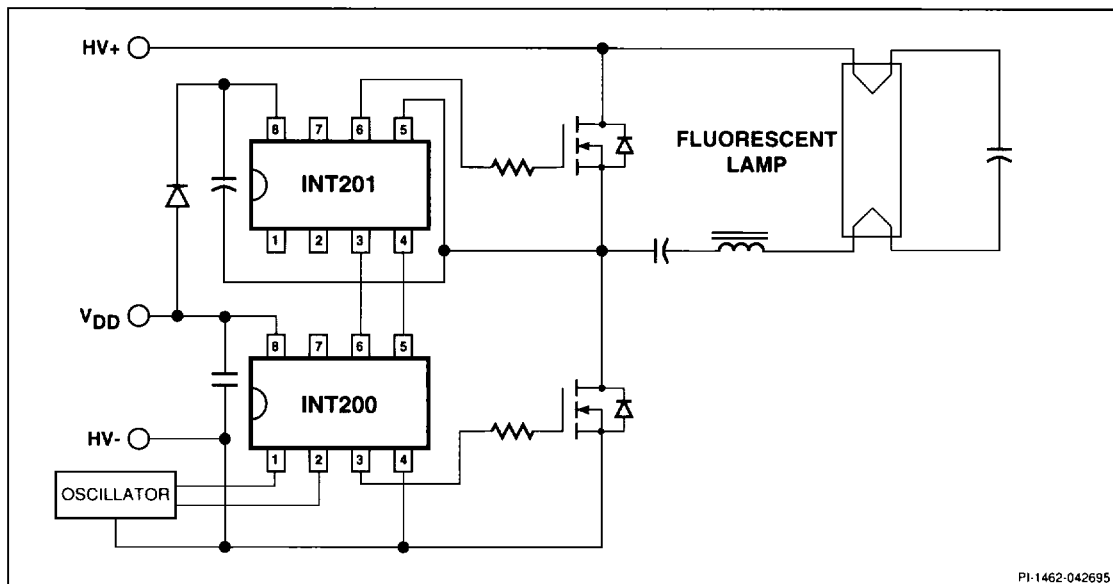


Figure 6. Using the INT200 and INT201 to Drive a Fluorescent Lamp.

HSD1/HSD2 Voltage (1 Suffix)	600 V
(2 Suffix)	800 V
HSD1/HSD2 Slew Rate	10 V/ns
V_{DD} Voltage	16.5 V
Logic Input Voltage	-0.3V to 5.5 V
LS OUT Voltage	-0.3 V to $V_{DD} + 0.3$ V
Storage Temperature	-65 to 125°C
Ambient Temperature	-40 to 85°C
Junction Temperature	150°C
Lead Temperature ⁽²⁾	260°C

Power Dissipation

PF Suffix ($T_A = 25^\circ\text{C}$)	1.25 W
($T_A = 70^\circ\text{C}$)	800 mW
TF Suffix ($T_A = 25^\circ\text{C}$)	1.04 W
($T_A = 70^\circ\text{C}$)	667 mW

Thermal Impedance (θ_{JA})

PF Suffix	100°C/W
TF Suffix	120°C/W

1. Unless noted, all voltages referenced to COM, $T_A = 25^\circ\text{C}$
2. 1/16" from case for 5 seconds.

Parameter	Symbol	Conditions (Unless Otherwise Specified) $V_{DD} = 15$ V, COM = 0V $T_A = -40$ to 85°C	Min	Typ	Max	Units
Input Current, High or Low	I_{IH}, I_{IL}	$V_{IH} = 4.0$ V	0	10	150	μA
		$V_{IL} = 1.0$ V	-20	0	20	
Input Voltage High	V_{IH}		4.0			V
Input Voltage Low	V_{IL}				1.0	V
Input Voltage Hysteresis	V_{HY}		0.3	0.7		V
Breakdown Voltage	BV_{DSS}	1 Suffix	600	700		V
		2 Suffix	800	900		
Off-State Output Current	$I_{HSD(OFF)}$	$V_{HSD1}, V_{HSD2} = 500$ V		0.1	15	μA
On-State Output Current	$I_{HSD(ON)}$	$V_{HSD1}, V_{HSD2} = 10$ V	5	25		mA
On-State Pulse Width	$t_{HSD(ON)}$				156	ns
Output Capacitance	C_{OSS}	$V_{HSD1}, V_{HSD2} = 25$ V		10		pF

Parameter	Symbol	Conditions (Unless Otherwise Specified) $V_{DD} = 15\text{ V}$, $COM = 0\text{ V}$ $T_A = -40\text{ to }85^\circ\text{C}$		Min	Typ	Max	Units
Output Voltage High	V_{OH}	$I_o = -20\text{ mA}$		$V_{DD} - 1.0$	$V_{DD} - 0.5$		V
Output Voltage Low	V_{OL}	$I_o = 40\text{ mA}$			0.3	1.0	V
Output Short Circuit Current	I_{OS}	See Note 1	$V_o = 0\text{ V}$ $V_o = V_{DD}$			-150	mA
Turn-on Delay Time	$t_{d(on)}$	See Figure 7			0.6	1.0	μs
Rise Time	t_r	See Figure 7			80	120	ns
Turn-off Delay Time	$t_{d(off)}$	See Figure 7			0.5	1	μs
Fall Time	t_f	See Figure 7			50	100	ns
Deadtime (Low Off to High On)	Dt_{P+}	See Figure 8		0	450		ns
Deadtime (High Off to Low On)	Dt_{P-}	See Figure 8		0	300		ns
Input UV Trip-off Voltage	$V_{DD(UV)}$			8.5	9.0	10	V
Input UV Hysteresis				175	350		mV
Supply Current	I_{DD}	See Figure 2			1.5	3.0	mA
Supply Voltage	V_{DD}			10		16	V

NOTES:

1. Applying a short circuit to the LS OUT pin for more than 500 μ s will exceed the thermal rating of the package, resulting in destruction of the part.
2. V_{DD} supply must have less than 30 Ω output impedance.

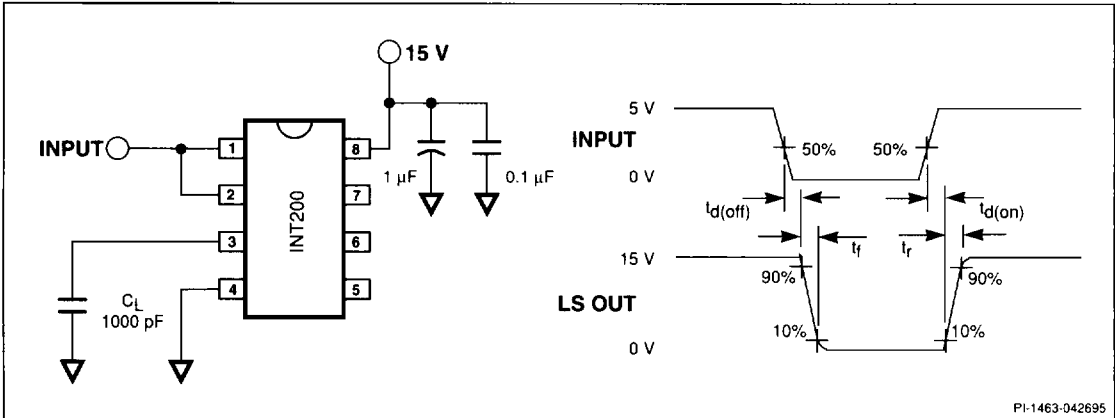


Figure 7. Switching Time Test Circuit.

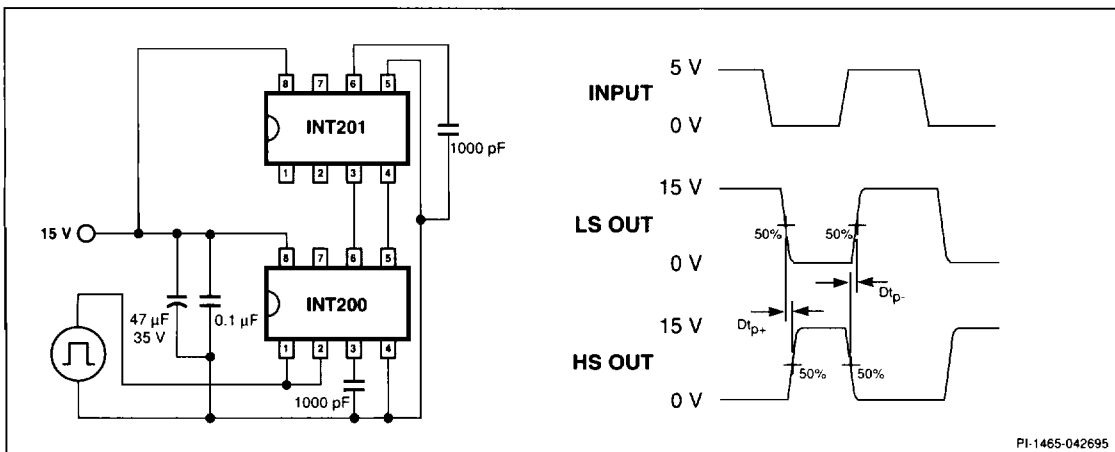
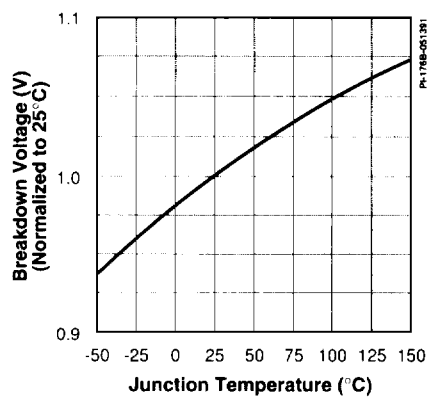


Figure 8. Dead Time Test Circuit.

BREAKDOWN vs. TEMPERATURE



PACKAGE POWER DERATING

